

# DIM200WLS17-A000

# Chopper Module - Lower Arm Control

DS5698-1.2 July 2007 (LN25358)

## FEATURES

- Non Punch Through Silicon
- Isolated Copper Baseplate
- 10 µs Short Circuit Withstand
- Lead Free construction

## **APPLICATIONS**

- Choppers
- Motor Controllers
- Induction Heating
- Resonant Converters
- Power Supplies

The Powerline range of high power modules includes half bridge, chopper, dual, single and bidirectional switch configurations covering voltages from 1200V to 3300V and currents up to 3600A.

The DIM200WLS17-A000 is a half bridge 1700V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus full 10 $\mu$ s short circuit withstand.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### **ORDERING INFORMATION**

#### Order As:

#### DIM200WLS17-A000

Note: When ordering, please use the whole part number.

## KEY PARAMETERS

| V <sub>CES</sub>        |       | 1700V |
|-------------------------|-------|-------|
| V <sub>CE (sat)</sub> * | (typ) | 2.7 V |
| l <sub>c</sub> `´       | (max) | 200A  |
| I <sub>C(PK)</sub>      | (max) | 400A  |

\*(Measured at power busbars and not at auxiliary terminals)

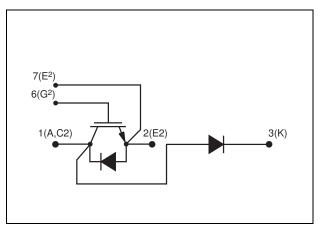


Fig. 1 Chopper circuit diagram

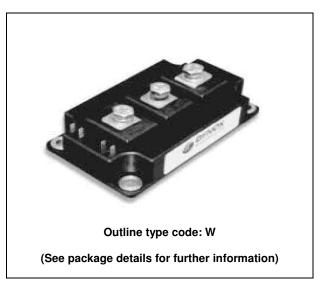


Fig. 2 Module outline



#### **ABSOLUTE MAXIMUM RATINGS - PER ARM**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

## Tcase = 25° C unless stated otherwise

| Symbol             | Parameter                               | Test Conditions                                       | Max. | Units             |
|--------------------|---|---|------|-------------------|
| V <sub>CES</sub>   | Collector-emitter voltage               | V <sub>GE</sub> = 0V                                  | 1700 | V                 |
| V <sub>GES</sub>   | Gate-emitter voltage                    |   | ±20  | V                 |
| Ι <sub>C</sub>     | Continuous collector current            | $T_{case} = 65 \circ C$                               | 200  | А                 |
| I <sub>C(PK)</sub> | Peak collector current                  | 1ms, T <sub>case</sub> =110°C                         | 400  | Α                 |
| P <sub>max</sub>   | Max. transistor power dissipation       | $T_{case} = 25 ^{\circ} C, T_{j} = 150 ^{\circ} C$    | 1390 | W                 |
| l <sup>2</sup> t   | Diode I <sup>2</sup> t value (IGBT arm) | $V_{R}$ = 0, $t_{P}$ = 10ms, $T_{vj}$ = 125 ° C       | 7.5  | kA <sup>2</sup> S |
| V <sub>isol</sub>  | Isolation voltage – per module          | Commoned terminals to base plate. AC RMS, 1 min, 50Hz | 4000 | V                 |

#### THERMAL AND MECHANICAL RATINGS

| Internal insulation material:  | $AI_2O_3$ |
|--------------------------------|-----------|
| Baseplate material:            | Copper    |
| Creepage distance:             | 24mm      |
| Clearance:                     | 13mm      |
| CTI (Critical Tracking Index): | 175       |

| Symbol           | Parameter  | Test Conditions                               | Min. | Тур. | Max. | Units  |
|------------------|--|---|------|------|------|--------|
| $R_{th(j-c)}$    | Thermal resistance – transistor<br>(per arm)                               | Continuous dissipation –<br>junction to case  | -    | -    | 90   | ° C/kW |
| $R_{th(j-c)}$    | Thermal resistance – diode (per arm)<br>(Antiparallel and Freewheel diode) | Continuous dissipation –<br>junction to case  | -    | -    | 200  | ° C/kW |
| $R_{th(c-h)}$    | Thermal resistance – case to heatsink<br>(per module)                      | Mounting torque 5Nm<br>(with mounting grease) | -    | -    | 15   | ° C/kW |
| Tj               | Junction temperature   | Transistor                                    | -    | -    | 150  | °C     |
|                  |  | Diode   | -    | -    | 125  | °C     |
| T <sub>stg</sub> | Storage temperature range  | -   | -40  | -    | 125  | °C     |
| -                | Screw torque   | Mounting – M6                                 | 3    | -    | 5    | Nm     |
|                  |  | Electrical connections – M6                   | 2.5  | -    | 5    | Nm     |



### **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise.

| Symbol                  | Parameter                            | Test Conditions   | Min. | Тур. | Max. | Units |
|-------------------------|--------------------------------------|---|------|------|------|-------|
| I <sub>CES</sub>        | Collector cut-off current            | $V_{GE}$ = 0V, $V_{CE}$ = $V_{CES}$   | -    | -    | 1    | mA    |
|                         | (IGBT and Diode arm)                 | $V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125 \degree C$   | -    | -    | 6    | mA    |
| I <sub>GES</sub>        | Gate leakage current                 | $V_{GE} = \pm 20V, \ V_{CE} = 0V$   | -    | -    | 2    | μA    |
| $V_{\text{GE(TH)}}$     | Gate threshold voltage               | $I_{C} = 10mA, V_{GE} = V_{CE}$   | 4.5  | 5.5  | 6.5  | V     |
| $V_{CE(sat)}^{\dagger}$ | Collector-emitter saturation voltage | $V_{GE} = 15V, I_{C} = 200A$  | -    | 2.7  | 3.4  | V     |
|                         |                                      | $V_{GE}$ = 15V, I <sub>C</sub> = 200A, T <sub>case</sub> = 125 ° C  | -    | 3.4  | 4.0  | V     |
| I <sub>F</sub>          | Diode forward current                | DC  | -    | -    | 200  | А     |
| I <sub>FM</sub>         | Diode maximum forward current        | t <sub>p</sub> = 1ms  | -    | -    | 400  | А     |
| $V_{F}^{\dagger}$       | Diode forward voltage                | I <sub>F</sub> = 200A   | -    | 2.2  | 2.5  | V     |
|                         | (IGBT and Diode arm)                 | I <sub>F</sub> = 200A, T <sub>case</sub> = 125 ° C  | -    | 2.3  | 2.6  | V     |
| Cies                    | Input capacitance                    | $V_{CE}$ = 25V, $V_{GE}$ = 0V, f = 1MHz   | -    | 15   | -    | nF    |
| L <sub>M</sub>          | Module inductance per arm            | -   | -    | 20   | -    | nH    |
| R <sub>INT</sub>        | Internal resistance per arm          | -   | -    | 0.23 | -    | mΩ    |
|                         |                                      | $T_j = 125 ^{\circ} C, V_{cc} = 1000V,$ I <sub>1</sub>  | -    | 900  | -    | А     |
| SC <sub>Data</sub>      | Short circuit. I <sub>sc</sub>       | $\label{eq:logith} \begin{array}{l} t_p \leq 10 \mu s, \\ V_{CE(max)} = V_{CES} \text{ - } L^*.di/dt \\ \\ IEC \ 60747\text{-}9 \end{array} \end{array} \hspace{1.5cm} I_2$ | -    | 800  | -    | A     |

#### Note:

 $^{\rm t}$  Measured at the power busbars and not the auxiliary terminals \* L is the circuit inductance +  $L_{\rm M}$ 



#### **ELECTRICAL CHARACTERISTICS**

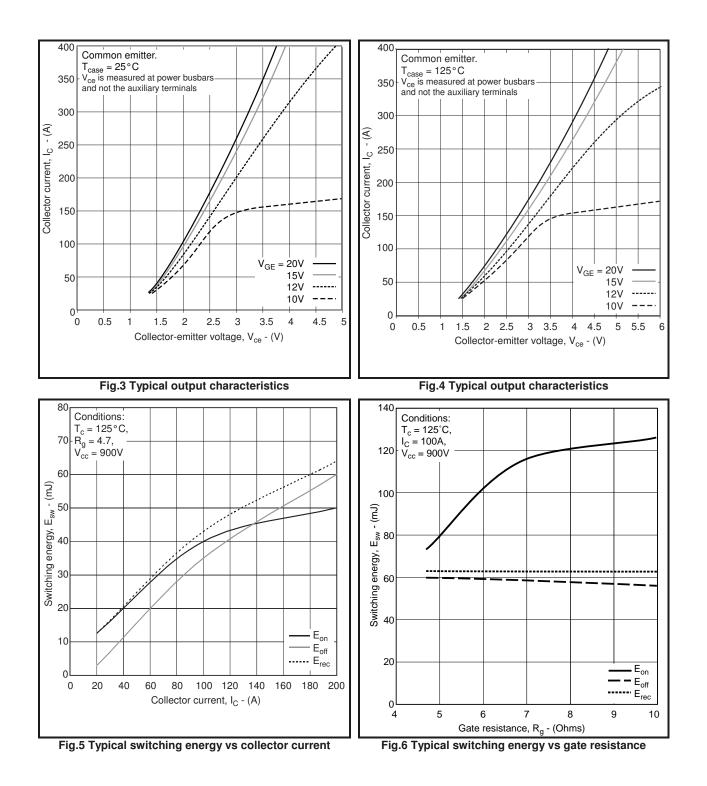
### T<sub>case</sub> = 25 ° C unless stated otherwise.

| Symbol              | Parameter                     | Test Conditions                                     | Min. | Тур. | Max. | Units |
|---------------------|-------------------------------|---|------|------|------|-------|
| t <sub>d(off)</sub> | Turn-off delay time           | I <sub>C</sub> = 200A                               | -    | 590  | -    | ns    |
| t <sub>f</sub>      | Fall time                     | $V_{GE} = \pm 15V$                                  | -    | 300  | -    | ns    |
| E <sub>OFF</sub>    | Turn-off energy loss          | $V_{CE} = 900V$                                     | -    | 40   | -    | mJ    |
| t <sub>d(on)</sub>  | Turn-on delay time            | $R_{G(ON)} = 4.7\Omega \ R_{G(OFF)} = 4.7 \ \Omega$ | -    | 320  | -    | ns    |
| t <sub>r</sub>      | Rise time                     | L ~ 100nH   | -    | 90   | -    | ns    |
| Eon                 | Turn-on energy loss           |   | -    | 50   | -    | mJ    |
| Qg                  | Gate charge                   |   | -    | 2    | -    | μC    |
| Qrr                 | Diode reverse recovery charge | $I_F = 200A, V_R = 900,$                            | -    | 65   | -    | μC    |
| Irr                 | Diode reverse current         | dI <sub>F</sub> /dt = 3000A/µs                      | -    | 195  | -    | Α     |
| E <sub>REC</sub>    | Diode reverse recovery energy |   | -    | 42   | -    | mJ    |

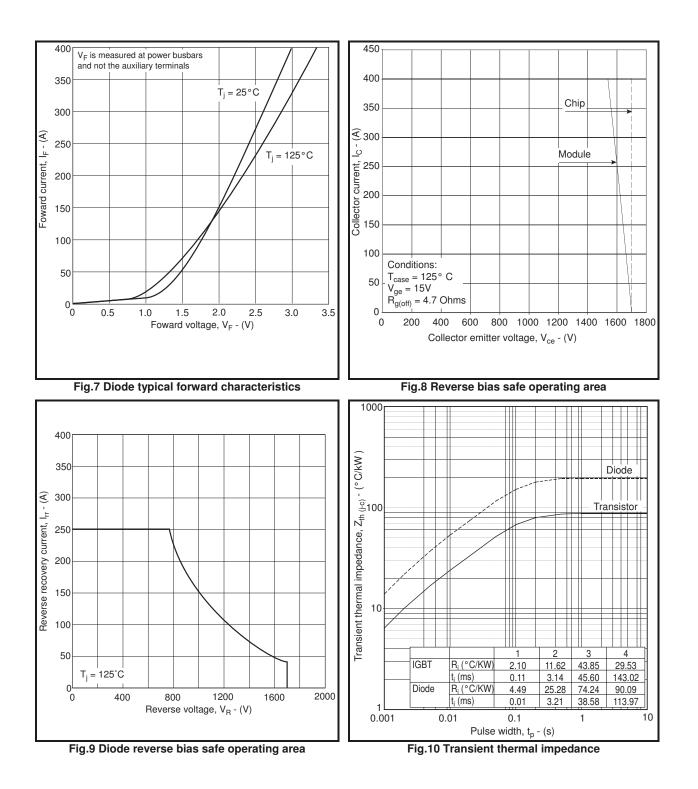
### T<sub>case</sub> = 125°C unless stated otherwise.

| Symbol              | Parameter                     | Test Conditions                                       | Min. | Тур. | Max. | Units |
|---------------------|-------------------------------|---|------|------|------|-------|
| t <sub>d(off)</sub> | Turn-off delay time           | I <sub>C</sub> = 200A                                 | -    | 880  | -    | ns    |
| t <sub>f</sub>      | Fall time                     | $V_{GE} = \pm 15V$                                    | -    | 410  | -    | ns    |
| E <sub>OFF</sub>    | Turn-off energy loss          | $V_{CE} = 900V$                                       | -    | 60   | -    | mJ    |
| t <sub>d(on)</sub>  | Turn-on delay time            | $R_{G(ON)} = 4.7 \ \Omega  R_{G(OFF)} = 4.7 \ \Omega$ | -    | 450  | -    | ns    |
| tr                  | Rise time                     | L ~ 100nH   | -    | 110  | -    | ns    |
| Eon                 | Turn-on energy loss           |   | -    | 85   | -    | mJ    |
| Qrr                 | Diode reverse recovery charge | $I_F = 200A, V_R = 900,$                              | -    | 100  | -    | μC    |
| I <sub>rr</sub>     | Diode reverse current         | $dI_F/dt = 2500A/\mu s$                               | -    | 195  | -    | А     |
| E <sub>REC</sub>    | Diode reverse recovery energy |   | -    | 64   | -    | mJ    |











### PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

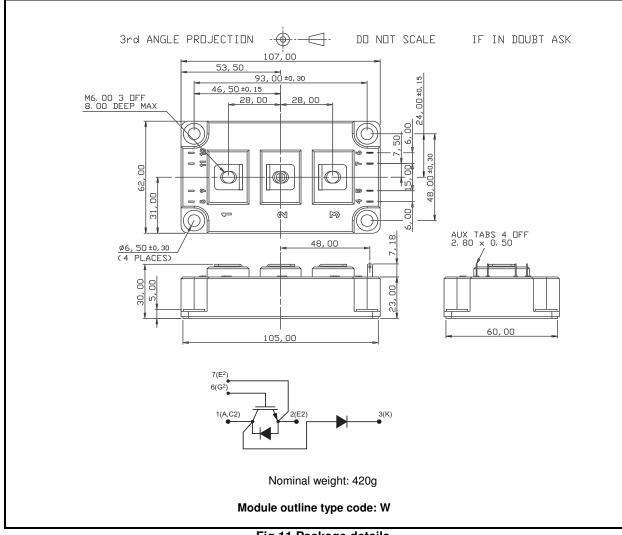


Fig.11 Package details



#### POWER ASSEMBLY CAPABILITY

The Power Assembly group was set up to provide a support service for those customers requiring more than the basic semiconductor, and has developed a flexible range of heatsink and clamping systems in line with advances in device voltages and current capability of our semiconductors.

We offer an extensive range of air and liquid cooled assemblies covering the full range of circuit designs in general use today. The Assembly group offers high quality engineering support dedicated to designing new units to satisfy the growing needs of our customers.

Using the latest CAD methods our team of design and applications engineers aim to provide the Power Assembly Complete Solution (PACs).

#### **HEATSINKS**

The Power Assembly group has its own proprietary range of extruded aluminium heatsinks which have been designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or Customer Services.

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Preliminary Information: The product is in design and development. The datasheet represents the product as it is understood but details may change.

Advance Information: The product design is complete and final characterisation for volume production is well in hand.

No Annotation: The product parameters are fixed and the product is available to datasheet specification

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